

<b>Notice of References Cited</b>	Application/Control No. 10/565,286	Applicant(s)/Patent Under Reexamination CHO ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 01/84930	11-2001	WO	Kang et al.	A01N 37/44
	O					
	P					
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**NON-PATENT DOCUMENTS**

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